WEST Search History

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DATE: Monday, April 25, 2005

Hide?	Set Name	Query	Hit Count
	DB=PGP	$^{\prime}B, USPT, USOC, EPAB, JPAB, DWPI, TDBD; PLUR=YESCON, SPAR SERVICE SERVICE$	S; OP=ADJ
	L19	134/\$.ccls. and (bellows accumulator)	1
	L18	L17 and (elevated pressure)	13
	L17	L15 and cleaning	408
	.L16	L15 and (dense gas)	4
	L15	134/\$.ccls. and (bladder or bellows)	594
	L14	(137/565.34).ccls. and conveying	11
	L13	(137/565.34).ccls. and accumulator and cleaning	8
\square	L12	(137/12 or 137/896).ccls. mixing	0
	L11	(137/12 or 137/896).ccls. and bellows	25
	L10	L9 and mixing	1
	L9	(137/12 or 137/896).ccls. and accumulator	13
	L8	L3 and wafer	1
	L7	L3 and cleaning	. 4
	L6	L3 and (supercritical gas)	0
Γ	L5	L3and and (supercritical gas)	0
	L4	L3and and (dense gas)	0
	L3	L2 and bellows	112
	L2	138/\$.ccls. and accumulator	1255
	Ll	138/4.ccls. and accumulator	0

END OF SEARCH HISTORY

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Search Results - Record(s) 1 through 4 of 4 returned.

1. Document ID: US 20050039775 A1

Using default format because multiple data bases are involved.

L16: Entry 1 of 4

File: PGPB

Feb 24, 2005

PGPUB-DOCUMENT-NUMBER: 20050039775

PGPUB-FILING-TYPE: new

DOCUMENT-IDENTIFIER: US 20050039775 A1

TITLE: Process and system for cleaning surfaces of semiconductor wafers

PUBLICATION-DATE: February 24, 2005

INVENTOR-INFORMATION:

NAME CITY STATE COUNTRY RULE-47

Whitlock, Walter H. Chapel Hill NC US

US-CL-CURRENT: <u>134/2</u>; <u>134/19</u>, <u>134/25.4</u>, <u>134/26</u>, <u>134/31</u>

Full Title: Citation Front Review Classification Date Reference Sequences Attachments Claims NMC Draw De

2. Document ID: US 20040003831 A1

L16: Entry 2 of 4 File: PGPB Jan 8, 2004

PGPUB-DOCUMENT-NUMBER: 20040003831

PGPUB-FILING-TYPE: new

DOCUMENT-IDENTIFIER: US 20040003831 A1

TITLE: Supercritical fluid cleaning process for precision surfaces

PUBLICATION-DATE: January 8, 2004

INVENTOR-INFORMATION:

NAME CITY STATE COUNTRY RULE-47

Mount, David J. North Andover MA US

US-CL-CURRENT: <u>134/26</u>; <u>134/30</u>, <u>134/42</u>, <u>134/902</u>

ABSTRACT:

A dry process for the cleaning of precision surfaces such as of semiconductor wafers, by using process materials such as carbon dioxide and useful additives such

Record List Display Page 2 of 4

as cosolvents and surfactants, where the process materials are applied exclusively in gaseous and supercritical states. Soak and agitation steps are applied to the wafer, including a rapid decompression of the process chamber after a soak period at higher supercritical pressure, to mechanically weaken break up the polymers and other materials sought to be removed, combined with a supercritical fluid flush to carry away the loose debris.

Full | Title: | Citation | Front: | Review | Classification | Date | Reference | Sequences | Attachments | Claims | KMC | Draw De

3. Document ID: US 20020014257 A1

L16: Entry 3 of 4

File: PGPB

Feb 7, 2002

PGPUB-DOCUMENT-NUMBER: 20020014257

PGPUB-FILING-TYPE: new

DOCUMENT-IDENTIFIER: US 20020014257 A1

TITLE: Supercritical fluid cleaning process for precision surfaces

PUBLICATION-DATE: February 7, 2002

INVENTOR-INFORMATION:

NAME	CITY	STATE	COUNTRY	RULE-47
Chandra, Mohan	Merrimack	NH	US	
Mount, David J.	North Andover	MA	US	
Costantini, Michael A.	Hudson	NH	US	
Moritz, Heiko D.	Nashua	NH	US	
Jafri, Ijaz H.	Nashua	NH	US	
Boyd, Jim	Amherst	NH	US	
Heathwaite, Rick M.	Greenfield	MA	US	

US-CL-CURRENT: <u>134/19</u>; <u>134/30</u>

ABSTRACT:

A dry process for the cleaning of precision surfaces such as of semiconductor wafers, by using process materials such as carbon dioxide and useful additives such as cosolvents and surfactants, where the process materials are applied exclusively in gaseous and supercritical states. Soak and agitation steps are applied to the wafer, including a rapid decompression of the process chamber after a soak period at higher supercritical pressure, to mechanically weaken break up the polymers and other materials sought to be removed, combined with a supercritical fluid flush to carry away the loose debris.

VISO VI	Full	Title: Citation Front Review Classification	n Date Reference Sequences Attachments Claims Kiwic	Drave De
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4. Document ID: US 6602349 B2

L16: Entry 4 of 4

File: USPT

Aug 5, 2003

Record List Display Page 3 of 4

US-PAT-NO: 6602349

DOCUMENT-IDENTIFIER: US 6602349 B2

TITLE: Supercritical fluid cleaning process for precision surfaces

DATE-ISSUED: August 5, 2003

INVENTOR-INFORMATION:

NAME CITY STATE ZIP CODE COUNTRY Chandra; Mohan Merrimack NH Mount; David J. North Andover MA Costantini; Michael A. Hudson NH Moritz; Heiko D. Nashua NH Jafri; Ijaz Nashua Boyd; Jim Amherst NH Heathwaite; Rick M. Manchester

US-CL-CURRENT: 134/19; 134/30, 134/34, 134/902

ABSTRACT:

A dry process for the cleaning of precision surfaces such as of semiconductor wafers, by using process materials such as carbon dioxide and useful additives such as cosolvents and surfactants, where the process materials are applied exclusively in gaseous and supercritical states. Soak and agitation steps are applied to the wafer, including a rapid decompression of the process chamber after a soak period at higher supercritical pressure, to mechanically weaken break up the polymers and other materials sought to be removed, combined with a supercritical fluid flush to carry away the loose debris.

27 Claims, 10 Drawing figures Exemplary Claim Number: 1 ... Number of Drawing Sheets: 10

Title: Citation: Front Review Classification Date Reference	Claims KW
Generate Collection Print Fwd Refs Bkwd Refs	Generate (
Term	Documents
DENSE	195596
DENSES	430
GAS	2631249
GASES	637360
(15 AND (DENSE ADJ GAS)).PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD.	4
(L15 AND (DENSE GAS)).PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD.	4

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Search Results - Record(s) 1 through 8 of 8 returned.

1. Document ID: US 6619318 B2

Using default format because multiple data bases are involved.

L13: Entry 1 of 8

File: USPT

Sep 16, 2003

US-PAT-NO: 6619318

DOCUMENT-IDENTIFIER: US 6619318 B2

TITLE: Multiple flow rate eductive dispenser

DATE-ISSUED: September 16, 2003

INVENTOR-INFORMATION:

NAME ,

CITY

STATE

COUNTRY

Dalhart; Mark D.

Mason

ОН

Sand; William F.

Cincinnati

ОН

 $\text{US-CL-CURRENT: } \underline{137}/\underline{565.34}; \ \underline{137}/\underline{565.22}, \ \underline{137}/\underline{599.12}, \ \underline{222}/\underline{571}, \ \underline{417}/\underline{181}, \ \underline{417}/\underline{46}$

Full Titl	le Citation Front Re	riew Classification	Date: Reference:	Claims 1000C	Draw, De

2. Document ID: US 5151175 A

L13: Entry 2 of 8

File: USPT

Sep 29, 1992

US-PAT-NO: 5151175

DOCUMENT-IDENTIFIER: US 5151175 A

TITLE: System to automatically drain filter backwash water

DATE-ISSUED: September 29, 1992

INVENTOR-INFORMATION:

NAME

CITY

STATE

ZIP CODE

ZIP CODE

COUNTRY

Royal; Claude S.

Lynchburg

VA

24501

US-CL-CURRENT: 210/108; 137/107, 137/565.34, 166/53, 210/257.1, 210/416.3, 210/418

ABSTRACT:

A system for providing filtered well water to a building includes a filter, an accumulator downstream of the filter, and an automatic backwash valve between the filter and the well. When the well pump is deactivated, the accumulator discharges

Record List Display Page 2 of 5

its contents back through the filter, towards the valve, which contains a shuttle that automatically diverts the backwash water to a drain line. The valve also prevents contaminants from being siphoned into the system through the drain line.

3 Claims, 3 Drawing figures Exemplary Claim Number: 1.
Number of Drawing Sheets: 3

3. Document ID: US 4877055 A

L13: Entry 3 of 8

File: USPT

Oct 31, 1989

US-PAT-NO: 4877055

DOCUMENT-IDENTIFIER: US 4877055 A

TITLE: Leakage device for the drainage of a diaphragm accumulator

DATE-ISSUED: October 31, 1989

INVENTOR-INFORMATION:

NAME CITY STATE ZIP CODE COUNTRY

Knuchel; Pierre Germigny L'Eveque FR
Nollez; Jacques Paris FR

US-CL-CURRENT: <u>137/565.34</u>; <u>138/30</u>, <u>138/40</u>, <u>60/413</u>

ABSTRACT:

The invention relates to a leakage device for the depletion of a diaphragm accumulator when the vehicle so equipped is not in use. This device determines a permanent leakage of the liquid to a low-pressure reservoir with a predetermined rate of flow. According to the embodiment of the invention shown in the attached drawing, the device comprises a rod (150) mounted in the plunger (110), and the leakage path is defined between the rod (150) and a narrowed zone (131) of an axial passage (132) located inside the plunger. Preferably, the plunger (110) comprises a bore (126) and passages (127, 134) in communication with the inlet port (104) and the outlet port (106), and a core (130) received in the bore (126), the axial passage (132) being formed in the core (130), and the rod (150) being mounted in the core (130). The invention is used for the braking of motor vehicles.

17 Claims, 6 Drawing figures Exemplary Claim Number: 1 Number of Drawing Sheets: 4

Full Title Citation Front Review Classification	
Full Title Citation Front Review Classification	Date Reference: Draw Dr

4. Document ID: US 3904131 A

L13: Entry 4 of 8 File: USPT Sep 9, 1975

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US-PAT-NO: 3904131

DOCUMENT-IDENTIFIER: US 3904131 A

TITLE: Pressure sewer system

DATE-ISSUED: September 9, 1975

INVENTOR-INFORMATION:

NAME CITY STATE ZIP CODE COUNTRY

Farrell, Jr.; R. Paul Schenectady NY Grace; Richard C. Carlisle NY Doyle; William J. Delanson NY

US-CL-CURRENT: 241/46.02; 137/565.34, 241/185.6

ABSTRACT:

A low pressure sewer system is described which employs grinder pumps for a multiplicity of sewage generating sites and which have semi-positive displacement pumping characteristics whereby substantially constant flow (in gallons per minute) output can be produced regardless of the pressure head of the sewage piping distribution main into which the pump discharges. Each grinder pump unit includes its own anti-siphoning protection as well as self-priming characteristics and further includes a redundant check valve in the discharge piping to the low pressure sewage collection main. The low pressure collection main is comprised by small diameter, flexible, non-corroding pipes that need only be buried under the frost line and can follow the contour of the terrain of the community in which the system is installed.

33 Claims, 5 Drawing figures Exemplary Claim Number: 1
Number of Drawing Sheets: 3

Full	Title Citation Front Review Classification	n Date Reference Claims KNMC D	raw. De

5. Document ID: US 3079948 A

L13: Entry 5 of 8 File: USOC Mar 5, 1963

US-PAT-NO: 3079948

DOCUMENT-IDENTIFIER: US 3079948 A

TITLE: Variable volume fluid distributor

DATE-ISSUED: March 5, 1963

INVENTOR-NAME: ALLEN ROBERT L

US-CL-CURRENT: <u>137/565.34</u>; <u>137/625.11</u>

Full Title: Citation Front Review Classification Date Reference

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6. Document ID: US 2896862 A

L13: Entry 6 of 8

File: USOC

Jul 28, 1959

US-PAT-NO: 2896862

DOCUMENT-IDENTIFIER: US 2896862 A

TITLE: Accumulator

DATE-ISSUED: July 28, 1959

INVENTOR-NAME: BEDE JAMES A

 $\text{US-CL-CURRENT: } \underline{239/332; } \underline{137/207}, \ \underline{137/565.34}, \ \underline{137/592}, \ \underline{138/26}, \ \underline{239/124}, \ \underline{239/135}$

Full Title: Citation Front: Review Classification Date Reference Claims NMC Draw Do

7. Document ID: US 2643616 A

L13: Entry 7 of 8

File: USOC

Jun 30, 1953

US-PAT-NO: 2643616

DOCUMENT-IDENTIFIER: US 2643616 A

TITLE: Pressure jet apparatus

DATE-ISSUED: June 30, 1953

INVENTOR-NAME: PAXTON DEWEY M

US-CL-CURRENT: <u>137/209</u>; <u>134/94.1</u>, <u>137/565.34</u>, <u>137/571</u>, <u>137/581</u>, <u>417/140</u>

Full Title: Citation: Front: Review: Classification: Date: Reference: Claims FXMC Draw De

8. Document ID: US 2207944 A

L13: Entry 8 of 8

File: USOC

Jul 16, 1940

US-PAT-NO: 2207944

DOCUMENT-IDENTIFIER: US 2207944 A

TITLE: Fluid actuated valve

DATE-ISSUED: July 16, 1940

INVENTOR-NAME: ADAMS RICHARDSON EDWARD

US-CL-CURRENT: 251/50; 137/340, 137/494, 137/565.34, 188/106P, 239/533.8, 251/63.6,

92/162R

Generate Collection Print Fwd Refs	Bkwd Refs General
Term	Documents
"137/565.34"	465
137/565.34S	
ACCUMULATOR	120110
ACCUMULATORS	24405
CLEANING	766294
CLEANINGS	3285
(("137/565.34".CCLS.) AND ACCUMULATOR AN CLEANING).PGPB,USPT,USOC,EPAB,JPAB,DWI	
((137/565.34).CCLS. AND ACCUMULATOR AND CLEANING).PGPB,USPT,USOC,EPAB,JPAB,DWI	

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